- Members of the Texas Instruments Widebus $+^{\text {TM }}$ Family
- State-of-the-Art EPIC-IIB ${ }^{\text {TM }}$ BiCMOS Design Significantly Reduces Power Dissipation
- UBT ${ }^{\text {TM }}$ (Universal Bus Transceiver) Combines D-Type Latches and D-Type Flip-Flops for Operation in Transparent, Latched, or Clocked Mode
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model ( $\mathrm{C}=200 \mathrm{pF}, \mathrm{R}=0$ )
- Latch-Up Performance Exceeds 500 mA Per JEDEC Standard JESD-17
- Released as DSCC SMD 5962-9557601NXD
- Typical Volp (Output Ground Bounce) $<0.8 \mathrm{~V}$ at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$
- High-Impedance State During Power Up and Power Down
- Distributed $V_{C C}$ and GND Pin Configuration Minimizes High-Speed Switching Noise
- High-Drive Outputs ( $-32-\mathrm{mA} \mathrm{I}_{\mathrm{OH}}, 64-\mathrm{mA} \mathrm{I}_{\mathrm{OL}}$ )
- Bus Hold on Data Inputs Eliminates the Need for External Pullup/Pulldown Resistors
- Package Options Include 100-Pin Plastic Thin Quad Flat (PZ) Package With $14 \times 14-\mathrm{mm}$ Body Using $0.5-\mathrm{mm}$ Lead Pitch and Space-Saving 100-Pin Ceramic Quad Flat (HS) Package ${ }^{\dagger}$

$\dagger$ The HS package is not production released.

SN54ABTH32501... HS PACKAGE $\dagger$
(TOP VIEW)

$\dagger$ For HS package availability, please contact the factory or your local TI Field Sales Office.

## description

These 36-bit UBTs combine D-type latches and D-type flip-flops to allow data flow in transparent, latched, and clocked modes.
Data flow in each direction is controlled by output-enable (OEAB and $\overline{O E B A}$ ), latch-enable (LEAB and LEBA), and clock (CLKAB and CLKBA) inputs. For A-to-B data flow, the device operates in the transparent mode when LEAB is high. When LEAB is low, the A data is latched if CLKAB is held at a high or low logic level. If LEAB is low, the $A$ data is stored in the latch/flip-flop on the low-to-high transition of CLKAB. Data flow for $B$ to $A$ is similar to that of A to B , but uses $\overline{\mathrm{OEBA}}$, LEBA, and CLKBA.

Output-enable OEAB is active high. When OEAB is high, the outputs are active. When OEAB is low, the outputs are in the high-impedance state. The output enables are complementary (OEAB is active high, and $\overline{O E B A}$ is active low).
When $\mathrm{V}_{\mathrm{CC}}$ is between 0 and 2.1 V , the device is in the high-impedance state during power up or power down. However, to ensure the high-impedance state above $2.1 \mathrm{~V}, \overline{\mathrm{OE}}$ should be tied to $\mathrm{V}_{\mathrm{CC}}$ through a pullup resistor and OE should be tied to GND through a pulldown resistor; the minimum value of the resistor is determined by the current-sinking/current-sourcing capability of the driver.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.
The SN54ABTH32501 is characterized for operation over the full military temperature range of $-55^{\circ} \mathrm{C}$ to $125^{\circ} \mathrm{C}$. The SN74ABTH32501 is characterized for operation from $-40^{\circ} \mathrm{C}$ to $85^{\circ} \mathrm{C}$.

FUNCTION TABLE $\dagger$

| INPUTS |  |  |  | $\begin{gathered} \text { OUTPUT } \\ \text { B } \end{gathered}$ |
| :---: | :---: | :---: | :---: | :---: |
| OEAB | LEAB | CLKAB | A |  |
| L | X | X | X | Z |
| H | H | X | L | L |
| H | H | X | H | H |
| H | L | $\uparrow$ | L | L |
| H | L | $\uparrow$ | H | H |
| H | L | H | X | $\mathrm{B}_{0} \ddagger$ |
| H | L | L | X | $\mathrm{B}_{0}$ § |

$\dagger$ A-to-B data flow is shown: B -to-A flow is similar, but uses OEBA, LEBA, and CLKBA.
$\ddagger$ Output level before the indicated steady-state input conditions were established
§ Output level before the indicated steady-state input conditions were established, provided that CLKAB was low before LEAB went low

## WITH 3-STATE OUTPUTS

logic diagram (positive logic)


To 17 Other Channels


Pin numbers shown are for the PZ package.

# SN54ABTH32501, SN74ABTH32501 36-BIT UNIVERSAL BUS TRANSCEIVERS <br> WITH 3-STATE OUTPUTS <br> SCBS229F - JUNE 1992 - REVISED MAY 1997 

absolute maximum ratings over operating free-air temperature range (unless otherwise noted) $\dagger$

recommended operating conditions (see Note 3)


NOTE 3: Unused control pins must be held high or low to prevent them from floating.
electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.
$\ddagger$ This parameter is specified by characterization.
§ Not more than one output should be tested at a time, and the duration of the test should not exceed one second.
IT This is the increase in supply current for each input that is at the specified TTL voltage level rather than $\mathrm{V}_{\mathrm{CC}}$ or GND.
timing requirements over recommended ranges of supply voltage and operating free-air temperature (unless otherwise noted) (see Figure 1)

|  |  |  | 4AB | 2501 | 74AB | 2501 |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | MAX | MIN | MAX | UNIT |
| ${ }^{\text {f clock }}$ | Clock frequency |  | 0 | 150 | 0 | 150 | MHz |
|  | Pulse duration | LE high | 3.5 |  | 3.3 |  |  |
| tw | Pulse duration | CLK high or low | 3.5 |  | 3.3 |  | ns |
|  | Setup time | A or B before CLK $\uparrow$ | 4.3 |  | 3.5 |  |  |
| tsu | Setup time | A or B before LE $\downarrow$ | 2.5 |  | 1.6 |  | ns |
|  | Hold time | A or B after CLK $\uparrow$ | 0.2 |  | 0 |  | S |
| th | Hold time | A or B after LE $\downarrow$ | 1.8 |  | 1.6 |  | ns |

switching characteristics over recommended ranges of supply voltage and operating free-air temperature, $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$ (unless otherwise noted) (see Figure 1)

| PARAMETER | $\begin{aligned} & \text { FROM } \\ & \text { (INPUT) } \end{aligned}$ | TO (OUTPUT) | SN54ABTH32501 |  |  | SN74ABTH32501 |  |  | UNIT |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  | MIN | TYP $\dagger$ | MAX | MIN | TYP $\dagger$ | MAX |  |
| $f_{\text {max }}$ |  |  | 150 |  |  | 150 |  |  | MHz |
| tPLH | A or B | B or A | 0.5 | 2.9 | 5.2 | 1.3 | 2.9 | 4.8 | ns |
| tPHL |  |  | 0.5 | 2.7 | 5.8 | 1.4 | 2.7 | 5.4 |  |
| tPLH | LEAB or LEBA | A or B | 0.7 | 3.4 | 5.7 | 1.6 | 3.4 | 5.3 | ns |
| tPHL |  |  | 0.7 | 3.6 | 5.9 | 1.9 | 3.6 | 5.5 |  |
| tPLH | CLKAB or CLKBA | A or B | 0.5 | 3.2 | 5.7 | 1.5 | 3.2 | 5.3 | ns |
| tPHL |  |  | 0.7 | 3.3 | 5.8 | 1.7 | 3.3 | 5.4 |  |
| tPZH | OEAB or $\overline{\text { OEBA }}$ | A or B | 0.5 | 3.2 | 6.2 | 1.2 | 3.2 | 5.6 | ns |
| tPZL |  |  | 0.5 | 3.6 | 6.6 | 1.5 | 3.6 | 6 |  |
| tPHZ | OEAB or $\overline{\text { OEBA }}$ | A or B | 0.7 | 3.6 | 7 | 1.8 | 3.6 | 5.9 | ns |
| tPLZ |  |  | 0.7 | 3.5 | 6.1 | 1.7 | 3.5 | 5.6 |  |

$\dagger$ All typical values are at $\mathrm{V}_{\mathrm{CC}}=5 \mathrm{~V}, \mathrm{~T}_{\mathrm{A}}=25^{\circ} \mathrm{C}$.

## PARAMETER MEASUREMENT INFORMATION



| TEST | S1 |
| :---: | :---: |
| tPLH/tPHL | Open |
| tpLZ/tPZL | 7 V |
| tPHZ/tPZH | Open |



VOLTAGE WAVEFORMS SETUP AND HOLD TIMES


NOTES: A. $C_{L}$ includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: $\mathrm{PRR} \leq 10 \mathrm{MHz}, \mathrm{Z}_{\mathrm{O}}=50 \Omega, \mathrm{t}_{\mathrm{r}} \leq 2.5 \mathrm{~ns}, \mathrm{t}_{\mathrm{f}} \leq 2.5 \mathrm{~ns}$.
D. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms

PACKAGE OPTION ADDENDUM

## PACKAGING INFORMATION

| Orderable Device | Status ${ }^{(1)}$ | Package <br> Type | Package <br> Drawing | Pins Package <br> Qty | Eco Plan ${ }^{(2)}$ | Lead/Ball Finish | MSL Peak Temp ${ }^{(3)}$ |  |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 5962-9557601NXD | OBSOLETE | LQFP | PZ | 100 | TBD | Call TI | Call TI |  |
| SN74ABTH32501PZ | ACTIVE | LQFP | PZ | 100 | 90 |  <br> no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR |
| SN74ABTH32501PZG4 | ACTIVE | LQFP | PZ | 100 | 90 |  <br> no Sb/Br) | CU NIPDAU | Level-3-260C-168 HR |

${ }^{(1)}$ The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but Tl does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.
${ }^{(2)}$ Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS \& no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb -Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed $0.1 \%$ by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb -Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.
Green (RoHS \& no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine ( Br ) and Antimony ( Sb ) based flame retardants ( Br or Sb do not exceed $0.1 \%$ by weight in homogeneous material)
${ }^{(3)}$ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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## OTHER QUALIFIED VERSIONS OF SN54ABTH32501, SN74ABTH32501 :

- Enhanced Product: SN74ABTH32501-EP

NOTE: Qualified Version Definitions:

- Enhanced Product - Supports Defense, Aerospace and Medical Applications


NOTES: A. All linear dimensions are in millimeters.
B. This drawing is subject to change without notice.
C. Falls within JEDEC MS-026

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